PHASE NOISE MEASUREMENT APPLICATION

Specifications

R&S[®]FSW-K40 R&S[®]FSMR3-K40 R&S[®]FSV3-K40 R&S[®]FPS-K40 R&S[®]FSV-K40 R&S[®]FPL1-K40



Data Sheet Version 08.00

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Definitions

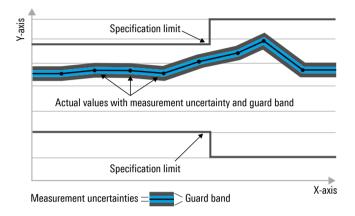
General

Product data applies under the following conditions:

- · Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- · All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as $\langle, \leq, \rangle, \geq, \pm$, or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP/3GPP2 standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bit per second (Gbps), million bit per second (Mbps), thousand bit per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, Msps, ksps and Msample/s are not SI units.

Specifications

The specifications of the R&S[®]FSx-K40 phase noise measurement application are based on the data sheet specifications of the:

- R&S[®]FSW signal and spectrum analyzer
- R&S[®]FSMR3000 measuring receiver
- R&S[®]FSVA3000 signal and spectrum analyzer
- R&S[®]FSV3000 signal and spectrum analyzer
- R&S[®]FPS signal and spectrum analyzer
- R&S[®]FSVA signal and spectrum analyzer
- R&S[®]FSV signal and spectrum analyzer
- R&S[®]FPL1000 signal and spectrum analyzer

They have not been checked separately and are not verified during instrument calibration. Measurement uncertainties are given as 95 % confidence intervals. The specified level measurement errors do not take into account systematic errors due to reduced signal to noise (S/N) ratio.

Frequency range	R&S [®] FSW-K40, RF input	same as R&S [®] FSW
	R&S [®] FSMR3-K40, RF input	same as R&S [®] FSMR3000
	R&S [®] FSV3-K40, RF input	same as R&S [®] FSVA3000/R&S [®] FSV3000
	R&S [®] FPS-K40, RF input	same as R&S [®] FPS
	R&S [®] FSV-K40, RF input	same as R&S [®] FSVA/R&S [®] FSV
	R&S [®] FPL1-K40, RF input	same as R&S [®] FPL1000
Offset frequency range		1 Hz to 1 GHz (9 decades)

Configuration

Measurement settings	frontend configuration	 nominal frequency and level attenuator control (auto/manual) electronic attenuator control (auto/manual) coupling (AC/DC)
	verification and tracking functions	 frequency verification and tracking level verification and tracking frequency and level tolerance values
	phase noise measurement	 measurement range sweep direction sweep type (normal, fast, AVG, manual)
		for sweep type manual: setting of RBW, average count and mode individually for each half decade or globally
Result configuration	phase noise limit line	 up to 5 ranges, configuration using: thermal noise range corner frequency and range slope
	limit lines	as in base instrument
	graphical	x-axis and y-axis scaling: automatic (once/always) or user-defined
	smoothing and spur removal	 trace smoothing factor smoothing type (linear/logarithmic) spur removal on/off, spur threshold
	trace configuration	 up to 6 traces clear/write, max., min., average, view smoothing on/off
	numeric: residual noise	 residual FM, residual PM, RMS jitter four measurement ranges: one complete measurement range or user-definable range three user-definable ranges with assignable trace
	numeric: spot noise	 measurement on all 10^x Hz offset five user-definable offset frequencies
	markers	four markers (normal/delta) with assignable trace

Display	 phase noise plot (dBc (1 Hz) versus logarithmic frequency) residual noise table spot noise table
Remote control	 GPIB LAN (VXI-11) control via SCPI command set and application-specific extensions

Results

Input frequency	Frequenc	y offset, values	in dBc (1 Hz)					
	1 Hz	10 Hz	100 Hz	1 kHz	10 kHz	200 kHz	1 MHz	10 MHz
100 MHz	-90	-110	-125	-137	-143	-145	-151.5	-158
500 MHz	-78	-106	-122	-135	-141	-145	-150.5	-157
1 GHz	-72	-100	-116	-132	-140	-143	-149.5	-156
2 GHz	-66	-94	-110	-125	-134	-137	-145	-158
10 GHz	-52	-80	-96	-122	-133	-136	-144	-156
25 GHz	-44	-72	-88	-114	-125	-128	-136	-148
40 GHz	-40	-68	-84	-110	-121	-124	-130	-142
60 GHz	-36	-64	-80	-106	-117	-120	-128	-140
80 GHz	-34	-62	-78	-104	-115	-118	-126	-136

R&S[®]FSMR3-K40: phase noise sensitivity (typical values) without noise correction,

input level > 0 dBm, operating mode: averaged, with R&S[®]FSMR3-B4 OCXO precision frequency reference option

Input frequency	Frequency offset, values in dBc (THZ)							
	1 Hz	10 Hz	100 Hz	1 kHz	10 kHz	200 kHz	1 MHz	10 MHz
100 MHz	-90	-110	-125	-137	-143	-145	-151.5	-158
500 MHz	-78	-106	-122	-135	-141	-145	-150.5	-157
1 GHz	-72	-100	-116	-132	-140	-143	-149.5	-156
2 GHz	-66	-94	-110	-125	-134	-137	-145	-158
10 GHz	-52	-80	-96	-122	-133	-136	-144	-156
25 GHz	-44	-72	-88	-114	-125	-128	-136	-148
50 GHz	-38	-66	-82	-108	–119	-122	-129	-141

R&S[®]FSV3-K40 on R&S[®]FSVA3000: phase noise sensitivity (typical values) without noise correction, input level > 0 dBm, operating mode: averaged

Input frequency	Frequency offset, values in dBc (1 Hz)									
	10 Hz	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz	10 MHz			
1 GHz	-80	-106	-120	-125	-128	-138	-152			
2 GHz	-65	-93	-114	-121	-124	-137	-151			
10 GHz	-58	-83	-108	-119	-122	-136	-150			
25 GHz	-55	-80	-103	-113	-116	-130	-144			
40 GHz	-53	-76	-100	-109	-112	-124	-138			
50 GHz	-50	-73	-97	-107	-110	-122	-136			
< 30 MHz	-97	-120	-131	-135.5	-137	-139	-153			

R&S[®]FSV3-K40 on R&S[®]FSV3000: phase noise sensitivity (typical values) without noise correction, input level > 0 dBm, operating mode: averaged

input level > 0 ubin, operating mode. averaged										
Input frequency	Frequency offset, values in dBc (1 Hz)									
	10 Hz	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz	10 MHz			
1 GHz	-75	-97	-109	-114	-119	-135	-150			
2 GHz	-65	-90	-104	-111	-116	-134	-148			
10 GHz	-58	-84	-100	-110	-115	-133	-147			
25 GHz	-55	-79	-95	-105	-110	-127	-141			
40 GHz	-51	-75	-91	-100	-105	-122	-136			
50 GHz	-48	-71	-88	-97	-102	-119	-133			

R&S[®]FPS-K40: phase noise sensitivity (typical values) without noise correction, input level > 0 dBm, operating mode: averaged

Input frequency	Frequency offset, values in dBc (1 Hz)								
	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz	10 MHz			
200 MHz	-90	-102	-110	–116	–135	-150			
500 MHz	-90	-102	-110	–116	–135	-150			
1 GHz	-88	-101	-110	–115	–135	-150			
3 GHz	-76	-98	-108	–115	–135	-150			
6 GHz	-70	-96	-105	–115	–135	-150			
12 GHz	-64	-90	-102	–115	–135	-150			
24 GHz	-58	-84	-96	-109	-129	-145			
38 GHz	-54	-80	-92	-105	-125	-141			
< 20 MHz	-118	-134	-142	-145	–145	-			

R&S[®]FSV-K40 on R&S[®]FSVA: phase noise sensitivity (typical values) without noise correction, input level > 0 dBm, operating mode: averaged

Input frequency	Frequency offset, values in dBc (1 Hz)							
	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz	10 MHz		
200 MHz	-101	–112	–118	-119	-141	-150		
500 MHz	-97	–112	-118	-119	-141	-150		
1 GHz	-91	-112	-118	-119	-141	-150		
3 GHz	-82	-110	-116	–117	-141	-150		
6 GHz	-78	-107	-114	-116	-141	-150		
12 GHz	-74	-101	-114	-116	-144	-150		
24 GHz	-68	-95	-108	-110	-138	-147		
38 GHz	-64	-92	-104	-106	-134	-143		
< 20 MHz	–118	-134	-142	–145	-145	-		

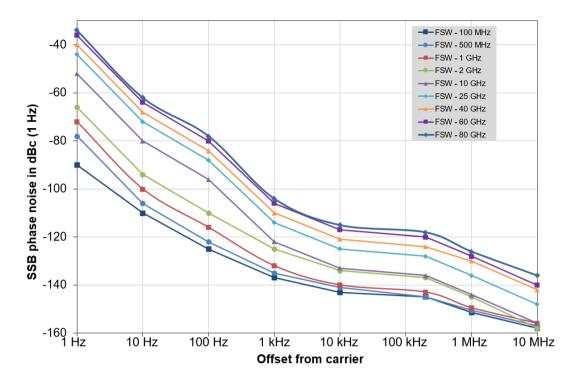
R&S[®]FSV-K40 on R&S[®]FSV: phase noise sensitivity (typical values) without noise correction,

input level > 0 dBm, operating mode: averaged									
Input frequency	Frequency offset, values in dBc (1 Hz)								
	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz	10 MHz			
200 MHz	-90	-102	-110	-116	-135	-150			
500 MHz	-90	-102	-110	-116	-135	-150			
1 GHz	-88	-101	-110	-115	-135	-150			
3 GHz	-76	-98	-108	-115	-135	-150			
6 GHz	-70	-96	-105	-115	-135	-150			
12 GHz	-64	-90	-102	–115	-135	-150			
24 GHz	-58	-84	-96	-109	-129	-145			
38 GHz	-54	-80	-92	-105	-125	–141			
< 20 MHz	-118	-134	-142	-145	-145	-			

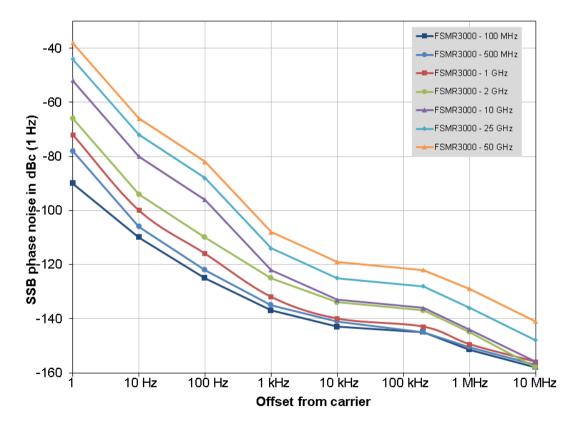
R&S[®]FPL1-K40 on R&S[®]FPL1000: phase noise sensitivity (typical values) without noise correction, input level > 0 dBm, operating mode: averaged

Input frequency Frequency offset, values in dBc (1 Hz)

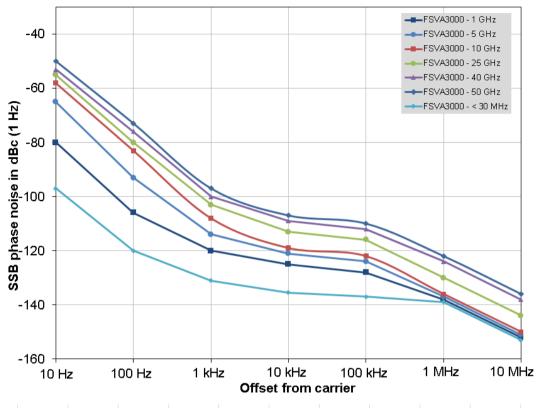
input frequency	Frequency offset, values in dBc (THZ)							
	100 Hz	1 kHz	10 kHz	100 kHz	1 MHz			
100 MHz	-108	-116	–111	–117	-137			
1 GHz	-98	-107	-108	-116	-137			
3 GHz	-78	-100	-105	-116	-137			
6 GHz	-73	-93	-102	–115	-132			
< 2 MHz	-123	-132	-146	-148	-150			



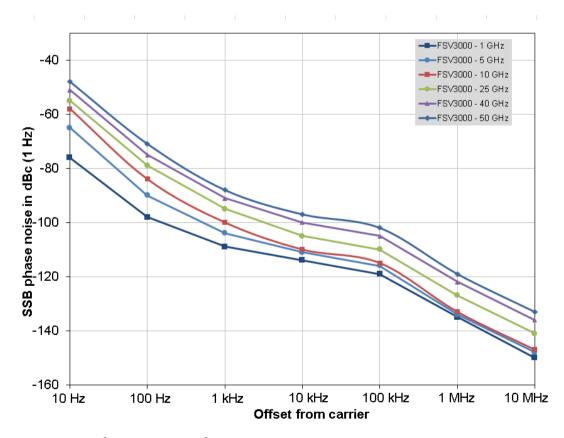
R&S[®]FSW-K40: typical phase noise at different center frequencies (with the R&S[®]FSW-B4 option for offsets ≤ 10 Hz)

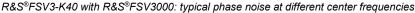


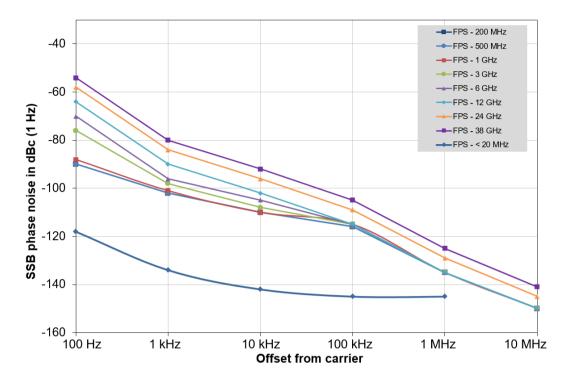
 $R\&S^{\circ}FSMR3-K40$: typical phase noise at different center frequencies (with the $R\&S^{\circ}FSMR3-B4$ option for offsets ≤ 10 Hz)



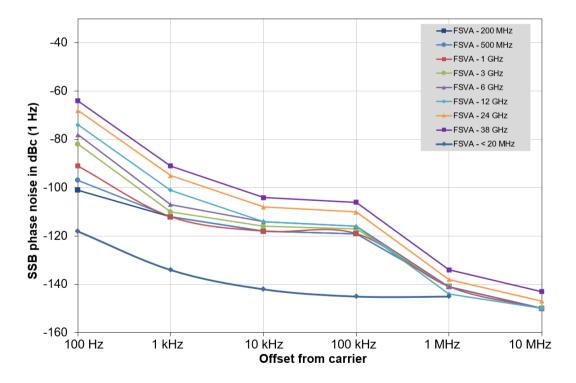
R&S®FSV3-K40 with R&S®FSVA3000: typical phase noise at different center frequencies



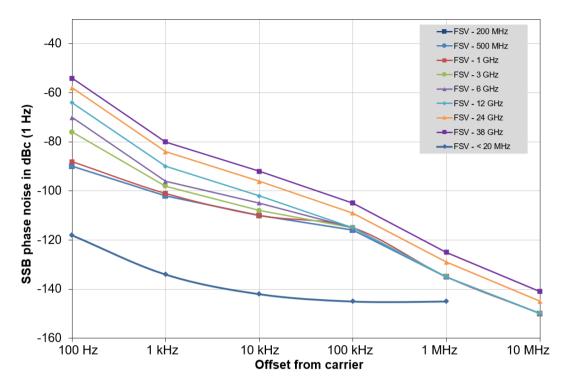




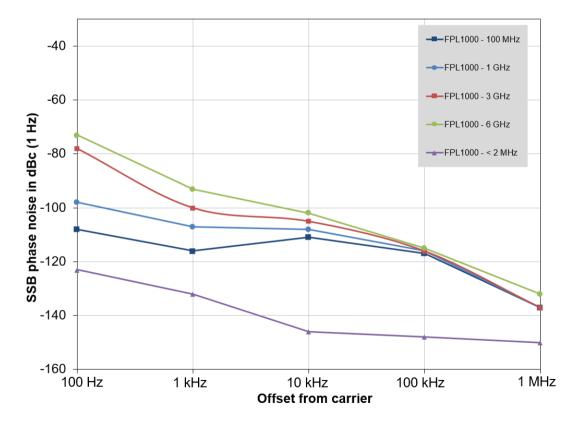
R&S[®]FPS-K40: typical phase noise at different center frequencies



R&S®FSV-K40 with R&S®FSVA: typical phase noise at different center frequencies



R&S®FSV-K40 with R&S®FSV: typical phase noise at different center frequencies



R&S®FPL1-K40 with R&S®FPL1000: typical phase noise at different center frequencies

Ordering information

Designation	Туре	Order No.
Phase noise measurement application	R&S [®] FSW-K40	1313.1397.02
Phase noise measurement application	R&S [®] FSMR3-K40	1345.3620.02
Phase noise measurement application	R&S [®] FSV3-K40	1330.5051.02
Phase noise measurement application	R&S [®] FPS-K40	1321.4110.02
Phase noise measurement application	R&S [®] FSV-K40	1310.8403.02
Phase noise measurement application	R&S [®] FPL1-K40	1323.1831.02

For R&S [®] FSW product brochure, see	PD 5215.6749.12
For R&S [®] FSW data sheet, see	PD 5215.6749.22
For R&S [®] FSMR3000 product brochure, see	PD 3608.5741.12
For R&S [®] FSMR3000 data sheet, see	PD 3608.5741.22
For R&S [®] FSVA3000 product brochure, see	PD 5216.1211.12
For R&S [®] FSVA3000 data sheet, see	PD 5216.1211.22
For R&S [®] FSV3000 product brochure, see	PD 5216.1334.12
For R&S [®] FSV3000 data sheet, see	PD 5216.1334.22
For R&S [®] FPS product brochure, see	PD 3606.9433.12
For R&S [®] FPS data sheet, see	PD 3606.9433.22
For R&S [®] FSVA product brochure, see	PD 3607.2790.12
For R&S [®] FSVA data sheet, see	PD 3607.2790.22
For R&S [®] FSV product brochure, see	PD 3606.7982.12
For R&S [®] FSV data sheet, see	PD 3606.7982.22
For R&S [®] FPL1000 product brochure, see	PD 5214.6974.12
For R&S [®] FPL1000 data sheet, see	PD 5214.6974.22

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